

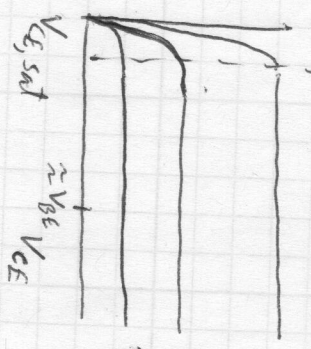
OH W11-12, F4-5

Device Models

BJT

MOS

$$I_c = I_s e^{V_{BE}/V_T} \left(1 + \frac{V_{CE}}{V_A} \right)$$



V_A typically 10-100V for discrete

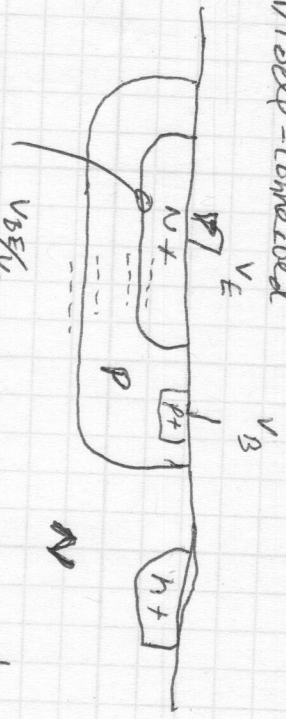
if $V_{BE} \gg V_T$

$$V_{CE} > V_{CE,sat}$$

$$V_{BE} = 626mV$$

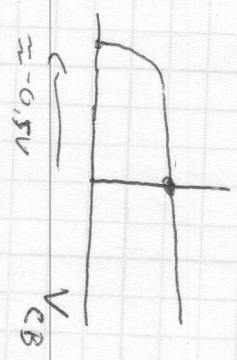
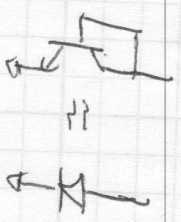
$$V_{BE} = 600mV \text{ (5k)}$$

"Diode-connected"



$I_e = I_s e^{V_{BE}/V_T}$
mostly e^- from emitter

$$V_{CB} = 0$$



$$g_m = \frac{\partial I_c}{\partial V_{BE}} = \frac{I_c}{V_T}$$

Very tough to do better

$$g_o = \frac{\partial I_c}{\partial V_{CE}} = I_s e^{V_{BE}/V_T} \frac{1}{V_A}$$

$$\frac{1}{V_A} = \frac{I_c}{V_A} \frac{1}{1 + \frac{V_{CE}}{V_A}}$$

$$r_o = \frac{1}{g_o} \approx \frac{V_A}{I_c}$$

intrinsic gain



← perfect current source

$$A_{v,small} = -g_m R_o = -\frac{I_c}{V_T} \frac{V_A}{I_c} = -\frac{V_A}{V_T} \approx \begin{cases} 1,000 \\ 4,000 \end{cases}$$

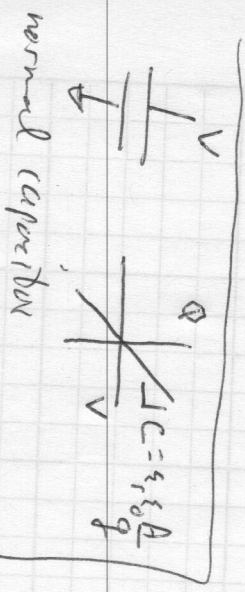
MOS capacitor

$V_G < 0$

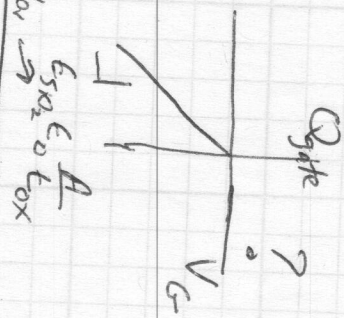


accumulation

(ignoring flatband voltage) μ

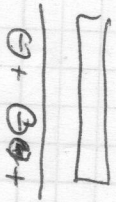


normal capacitor

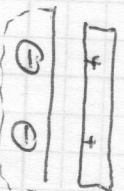


or other

$V_G = 0$

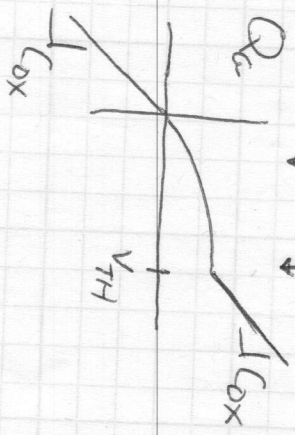
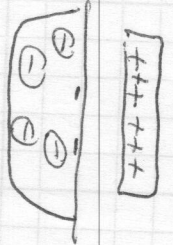


$V_G > 0$

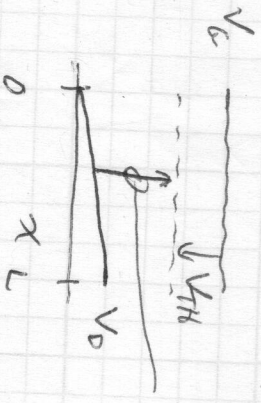
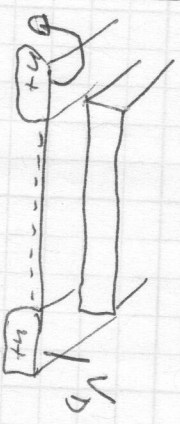


depletion

inversion



if $V_{GS} > V_{TH}$ and $V_{DS} < V_{GS} - V_{TH}$



Channel overdrive voltage average is

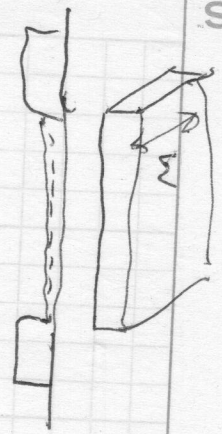
$$= \frac{V_G - V_{TH} - \frac{1}{2} V_{DS}}{2}$$

Charge density in the channel is proportional to $V_{GS} - V_{TH}$

$$Q_{CH} = C_{ox} (V_{GS} - V_{TH})$$

this is the part

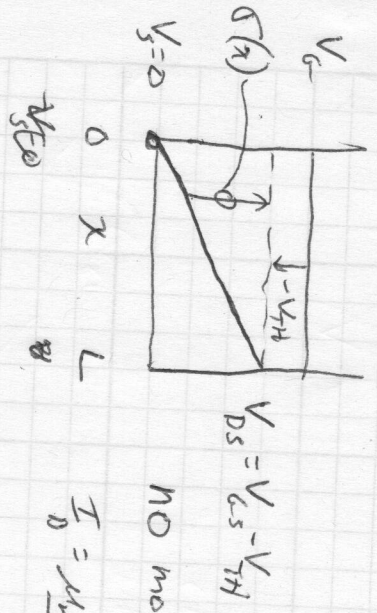
that does it some good



$I_D = (\text{avgs. charge per length}) (\text{velocity in } x)$

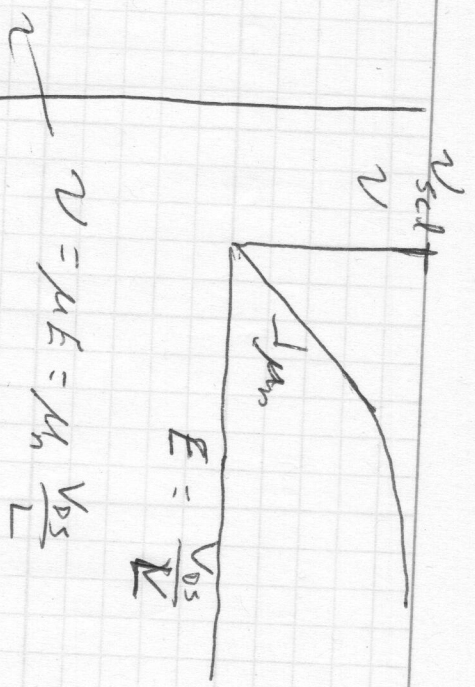
$$(W C_{ox} (V_{GS} - V_{th} - \frac{1}{2} V_{DS})) v$$

$$I_D = \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{th} - \frac{1}{2} V_{DS}) V_{DS}$$

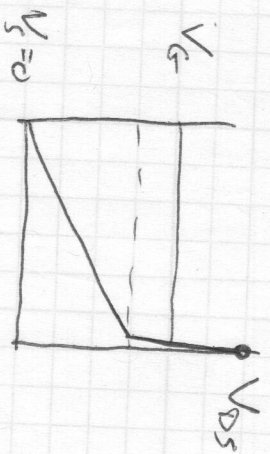


NO mobile charge at drain

$$I_D = \frac{\mu_n C_{ox} W}{2} L (V_{GS} - V_{th})^2$$



$$v = \mu_n E = \mu_n \frac{V_{DS}}{L}$$



$$I_D = \frac{\mu_n C_{ox} W}{2} L (V_{GS} - V_{th})^2 (1 + \lambda V_{DS})$$

odd for continuity (non-physical)